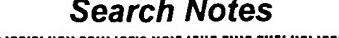


Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/729,661	DAVID H. SHEN
	Examiner	Art Unit
	DINH T. LE	2816

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner